INTERNATIONAL STANDARD



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Radionuclide imaging devices – Characteristics and test conditions

Part 2: Single photon emission computed tomographs

Dispositifs d'imagerie par radionucléides Caractéristiques et conditions d'essais

Partie 2: Systèmes de tomographie d'émission à photon unique

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The attention of readers is drawn to the end pages of this publication which list the IEC publications issued by the technical committee which has prepared the present publication.

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INTERNATIONAL ELECTROTECHNICAL COMMISSION

RADIONUCLIDE IMAGING DEVICES – CHARACTERISTICS AND TEST CONDITIONS –

Part 2: Single photon emission computed tomographs

FOREWORD

- 1) The IEC (International Electrotechnical Commission) is a worldwide organization for standardization comprising all national electrotechnical committees (IEC National Committees). The object of the IEC is to promote international co-operation on all questions concerning standardization in the electrical and electronic tields. To this end and in addition to other activities, the IEC publishes International Standards. Their preparation is entrusted to technical committees; any IEC National Committee interested in the subject dealt with may participate in this preparatory work. International, governmental and non-governmental organizations liaising with the IEC also participate in this preparation. The IEC collaborates closely with the International Organization for Standardization (ISO) in accordance with conditions determined by agreement between the two organizations.
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International Standard IEC 61675-2 has been prepared by subcommittee 62C: Equipment for radiotherapy, nuclear medicine and radiation dosimetry, of IEC technical committee 62: Electrical equipment in medical practice.

The text of this standard is based on the following documents:

$\langle \rangle$	FDIS	Report on voting
\checkmark	62C/206/FDIS	62C/215/RVD

Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

In this standard, the following print types are used:

- TERMS DEFINED IN CLAUSE 2 OF THIS STANDARD OR LISTED IN ANNEX A: SMALL CAPITALS.

The requirements are followed by specifications for the relevant tests.

Annex A is for information only.

A bilingual version of this standard may be issued at a later date.

RADIONUCLIDE IMAGING DEVICES – CHARACTERISTICS AND TEST CONDITIONS –

Part 2: Single photon emission computed tomographs

1 General

1.1 Scope and object

This part of IEC 61675 specifies terminology and test methods for describing the characteristics of Anger type rotational GAMMA CAMERA SINGLE PHOTON EMISSION COMPUTED TOMOGRAPHS (SPECT), equipped with parallel hole collimators. As these systems are based on Anger type GAMMA CAMERAS this part of IEC 61675 shall be used in conjunction with IEC 60789. These systems consist of a gantry system, single or multiple DETECTOR HEADs and a computer system together with acquisition, recording, and display devices.

The test methods specified in this part of IEC 61675 have been selected to reflect as much as possible the clinical use of Anger type rotational GAMMA CAMERA SINGLE PHOTON EMISSION COMPUTED TOMOGRAPHS (SPECT). It is intended that the test methods be carried out by manufacturers thereby enabling them to describe the characteristics of SPECT systems on a common basis.

No test has been specified to characterize the uniformity of reconstructed images because all methods known so far will mostly reflect the noise of the image.

1.2 Normative references

The following normative documents contain provisions which, through reference in this text, constitute provisions of this part of IEC 61675. At the time of publication, the editions indicated were valid. All normative documents are subject to revision, and parties to agreements based on this part of IEC 61675 are encouraged to investigate the possibility of applying the most recent editions of the normative documents indicated below. Members of IEC and ISO maintain registers of currently valid International Standards.

IEC 60788:1984 Medical radiology - Terminology

IEC 60789:1992, Characteristics and test conditions of radionuclide imaging devices – Anger type gamma cameras

IEC 61675-1, — Radionuclide imaging devices – Characteristics and test conditions – Part 1: Positron emission tomographs

2 Terminology and definitions

For the purpose of this part of IEC 61675 the definitions given in IEC 60788, IEC 60789 and IEC 61675-1 (see annex A), and the following definitions apply.

Defined terms are printed in small capital letters.

2.1

SYSTEM AXIS

Axis of symmetry characterized by geometrical and physical properties of the arrangement of the system

NOTE - The SYSTEM AXIS of a GAMMA CAMERA with rotating detectors is the axis of rotation.

2.1.1

COORDINATE SYSTEMS

2.1.2

FIXED COORDINATE SYSTEM

Cartesian system with axes X, Y, and Z, Z being the SYSTEM AXIS. The origin of the FIXED COORDINATE SYSTEM is defined by the centre of the TOMOGRAPHIC VOLUME (see figure 1). The SYSTEM AXIS is orthogonal to all TRANSVERSE SLICES.

2.1.3

COORDINATE SYSTEM OF PROJECTION

Cartesian system of the IMAGE MATRIX of each two-dimensional projection with axes X_p and Y_p (defined by the axes of the IMAGE MATRIX). The Y_p axis and the projection of the system axis onto the detector front face have to be in parallel. The origin of the COORDINATE SYSTEM OF PROJECTION is the centre of the IMAGE MATRIX (see figure 1).

2.1.4

CENTRE OF ROTATION (COR)

Origin of that COORDINATE SYSTEM, which describes the PROJECTIONS of a TRANSVERSE SLICE with respect to their orientation in space

NOTE - The CENTRE OF ROTATION of a TRANSVERSE SLICE is given by the intersection of the SYSTEM AXIS with the mid-plane of the corresponding OBJECT SLICE.

2.1.5

OFFSET

Deviation of the position of the projection of the COR (X'_p) from $X_p = 0$. (See figure 1)

2.2

TOMOGRAPHY (see annex A)

2.2.1

TRANSVERSE TOMOGRAPHY

In TRANSVERSE TOMOGRAPHY the three-dimensional object is sliced by physical methods, e.g. collimation, into a stack of OBJECT SLICES, which are considered as being two-dimensional and independent from each other. The transverse image planes are perpendicular to the SYSTEM AXIS.

2.2.2

EMISSION COMPUTED TOMOGRAPHY (ECT)

Imaging method for the representation of the spatial distribution of incorporated RADIONUCLIDES in selected two-dimensional SLICES through the object

2.2.2.1

PROJECTION

Transformation of a three-dimensional object into its two-dimensional image or of a twodimensional object into its one-dimensional image, by integrating the physical property which determines the image along the direction of the PROJECTION BEAM

NOTE – This process is mathematically described by line integrals in the direction of projection and called the Radon-transform.

2.2.2.2

PROJECTION BEAM

Determines the smallest possible volume in which the physical property which determines the image is integrated during the measurement process. Its shape is limited by the SPATIAL RESOLUTION in all three dimensions.

NOTE - In SPECT the PROJECTION BEAM usually has the shape of a long thin diverging cone.

2.2.2.3

PROJECTION ANGLE

Angle at which the **PROJECTION** is measured or acquired

NOTE – For illustration see figure 1.

2.2.2.4

SINOGRAM

Two-dimensional display of all one-dimensional PROJECTIONS of an object slice, as a function of the PROJECTION ANGLE

The PROJECTION ANGLE is displayed on the ordinate. The linear PROJECTION coordinate is displayed on the abscissa.

2.2.2.5

OBJECT SLICE

A slice in the object. The physical property of this slice that determines the measured information is displayed in the tomographic image.

2.2.2.6

IMAGE PLANE

A plane assigned to a plane in the OBJECT SLICE

NOTE - Usually the IMAGE PLANE is the mid-plane of the corresponding OBJECT SLICE.

2.2.2.7

TOMOGRAPHIC VOLUME

PROJECTION ANGLES

NOTE – For a rotating GAMMA CAMERA with a circular field of view the TOMOGRAPHIC VOLUME is a sphere provided that the radius of rotation is larger than the radius of the field of view. For a rectangular field of view, the TOMOGRAPHIC VOLUME is a cylinder.

2.2.2.7.1

TRANSVERSE FIELD OF VIEW

Dimensions of a slice through the TOMOGRAPHIC VOLUME, perpendicular to the SYSTEM AXIS. For a circular TRANSVERSE FIELD OF VIEW it is described by its diameter.

NOTE – For non-cylindrical TOMOGRAPHIC VOLUMES the TRANSVERSE FIELD OF VIEW may depend on the axial position of the slice.

2.2.2.7.2

AXIAL FIELD OF VIEW

Dimensions of a slice through the TOMOGRAPHIC VOLUME parallel to and including the SYSTEM AXIS. In practice it is specified only by its axial dimension given by the distance between the centres of the outermost defined IMAGE PLANES plus the average of the measured AXIAL SLICE WIDTH measured as EQUIVALENT WIDTH (EW).

2.2.2.7.3

TOTAL FIELD OF VIEW Dimensions (three-dimensional) of the TOMOGRAPHIC VOLUME

2.3

IMAGE MATRIX

Arrangement of MATRIX ELEMENTS in a preferentially cartesian coordinate system

2.3.1

MATRIX ELEMENT

Smallest unit of an IMAGE MATRIX, which is assigned in location and size to a certain volume element of the object (VOXEL)

2.3.1.1

PIXEL

MATRIX ELEMENT in a two-dimensional IMAGE MATRIX

2.3.1.2

TRIXEL

MATRIX ELEMENT in a three-dimensional IMAGE MATRIX

2.3.2

VOXEL

Volume element in the object which is assigned to a MATRIX ELEMENT in the IMAGE MATRIX (twodimensional or three-dimensional). The dimensions of the VoxEL are determined by the dimensions of the corresponding MATRIX ELEMENT via the appropriate scale factors and by the system's SPATIAL RESOLUTION in all three dimensions.

2.4

POINT SPREAD FUNCTION (PSF)

Scintigraphic image of a POINT SOURCE

2.4.1

PHYSICAL POINT SPREAD FUNCTION

For tomographs, a two-dimensional ROINT SPREAD FUNCTION in planes perpendicular to the PROJECTION BEAM at specified distances from the detector

NOTE – The PHYSICAL COINT SPREAD FUNCTION characterizes the purely physical imaging performance of the tomographic device independent from e.g. sampling, image reconstruction and image processing, but dependent on the COLLIMATOR. A PROJECTION BEAM Is characterized by the entirety of all PHYSICAL POINT SPREAD FUNCTIONS as a function of distance along its axis.

2.4.2

AXIAL POINT SPREAD FUNCTION

Profile passing through the peak of the PHYSICAL POINT SPREAD FUNCTION in a plane parallel to the SYSTEM AXIS

2.4.3

TRANSVERSE POINT SPREAD FUNCTION

Reconstructed two-dimensional POINT SPREAD FUNCTION in a tomographic IMAGE PLANE

NOTE – In TOMOGRAPHY, the TRANSVERSE POINT SPREAD FUNCTION can also be obtained from a line source located parallel to the SYSTEM AXIS.

2.5

SPATIAL RESOLUTION

Ability to concentrate the count density distribution in the image of a POINT SOURCE to a point

2.5.1

TRANSVERSE RESOLUTION

SPATIAL RESOLUTION in a reconstructed plane perpendicular to the SYSTEM AXIS

2.5.1.1

RADIAL RESOLUTION

TRANSVERSE RESOLUTION along a line passing through the position of the source and the system $\ensuremath{\mathsf{AXIS}}$

2.5.1.2

TANGENTIAL RESOLUTION

TRANSVERSE RESOLUTION in the direction orthogonal to the direction of RADIAL RESOLUTION

2.5.2

AXIAL RESOLUTION

For tomographs with sufficiently fine axial sampling fulfilling the sampling theorem, SPATIAL RESOLUTION along a line parallel to the SYSTEM AXIS

2.5.3

EQUIVALENT WIDTH (EW)

Width of that rectangle having the same area and the same height as the response function, e.g. the POINT SPREAD FUNCTION

2.6 Tomographic sensitivity

2.6.1

SLICE SENSITIVITY

Ratio of COUNT RATE as measured on the SINOGRAM to the ACTIVITY concentration in the phantom

NOTE - In SPECT the measured counts are not numerically corrected for scatter by subtracting the SCATTER FRACTION.

2.6.2

VOLUME SENSITIVITY

Sum of the individual SLICE SENSITIVITIES

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NORMALIZED VOLUME SENSITIVITY VOLUME SENSITIVITY divided by the AXIAL FIELD OF VIEW of the tomograph or the phantom length, whichever is the smaller

2.7

SCATTER FRACTION (SF)

Ratio between the number of scattered photons and the sum of scattered plus unscattered photons for a given experimental set-up

2.8

SINGLE PHOTON EMISSION COMPUTED TOMOGRAPHY (SPECT)

EMISSION COMPUTED TOMOGRAPHY utilizing single photon detection of gamma-ray emitting RADIONUCLIDES

2.8.1

DETECTOR POSITIONING TIME

Fraction of the total time spent on an acquisition which is not used in collecting data

2.8.2

DETECTOR HEAD TILT

Deviation of the COLLIMATOR axis from orthogonality with the SYSTEM AXIS